

# SANYO Semiconductors DATA SHEET

N-Channel Silicon MOSFET

# 2SK4098LS — General-Purpose Switching Device **Applications**

#### **Features**

- · Low ON-resistance, low input capacitance, ultrahigh-speed switching.
- · Adoption of high reliability HVP process.
- · Attachment workability is good by Mica-less package.
- · Avalanche resistance guarantee.

## **Specifications**

#### Absolute Maximum Ratings at Ta=25°C

| Parameter                          | Symbol                | Conditions   | Ratings     | Unit |
|------------------------------------|-----------------------|--|-------------|------|
| Drain-to-Source Voltage            | V <sub>DSS</sub>      |  | 600         | V    |
| Gate-to-Source Voltage             | VGSS                  |  | ±30         | V    |
| Drain Current (DC)                 | I <sub>Dc</sub> *1    | Limited only by maximum temperature                  | 7           | Α    |
|                                    | I <sub>Dpack</sub> *2 | Tc=25°C (SANYO's ideal heat dissipation condition)*3 | 6           | Α    |
| Drain Current (Pulse)              | IDP                   | PW≤10μs, duty cycle≤1%                               | 28          | Α    |
| Allowable Power Dissipation        | Do                    |  | 2.0         | W    |
|                                    | PD                    | Tc=25°C (SANYO's ideal heat dissipation condition)*3 | 33          | W    |
| Channel Temperature                | Tch                   |  | 150         | °C   |
| Storage Temperature                | Tstg                  |  | -55 to +150 | °C   |
| Avalanche Energy (Single Pulse) *4 | EAS                   |  | 292         | mJ   |
| Avalanche Current *5               | IAV                   |  | 7           | Α    |

<sup>\*1</sup> Shows chip capability

The method is applying silicone grease to the backside of the device and attaching the device to water-cooled radiator made of aluminium.

Marking: K4098

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<sup>\*2</sup> Package limited

<sup>\*3</sup> SANYO's condition is radiation from backside.

<sup>\*4</sup> VDD=99V, L=10mH, IAV=7A

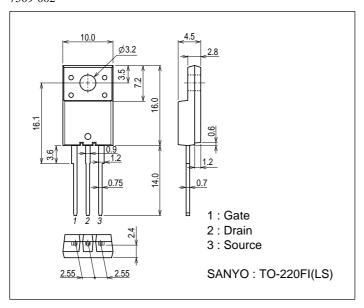
<sup>\*5</sup> L≤10mH, single pulse

## Electrical Characteristics at Ta=25°C

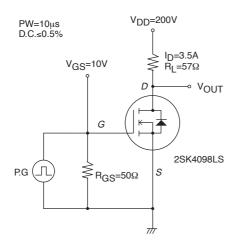
| Parameter                                  | Symbol               | Conditions  | Ratings |      |      | Unit  |
|--|----------------------|---|---------|------|------|-------|
|  |                      |   | min     | typ  | max  | Offit |
| Drain-to-Source Breakdown Voltage          | V(BR)DSS             | ID=10mA, VGS=0V   | 600     |      |      | V     |
| Zero-Gate Voltage Drain Current            | IDSS                 | V <sub>DS</sub> =480V, V <sub>GS</sub> =0V                      |         |      | 100  | μΑ    |
| Gate-to-Source Leakage Current             | IGSS                 | VGS=±30V, VDS=0V  |         |      | ±100 | nA    |
| Cutoff Voltage                             | Vgs(off)             | V <sub>DS</sub> =10V, I <sub>D</sub> =1mA                       | 3       |      | 5    | ٧     |
| Forward Transfer Admittance                | yfs                  | V <sub>DS</sub> =10V, I <sub>D</sub> =3.5A                      | 2.1     | 4.2  |      | S     |
| Static Drain-to-Source On-State Resistance | RDS(on)              | ID=3.5A, VGS=10V  |         | 0.9  | 1.1  | Ω     |
| Input Capacitance                          | Ciss                 | V <sub>DS</sub> =30V, f=1MHz                                    |         | 600  |      | pF    |
| Output Capacitance                         | Coss                 | V <sub>DS</sub> =30V, f=1MHz                                    |         | 120  |      | pF    |
| Reverse Transfer Capacitance               | Crss                 | V <sub>DS</sub> =30V, f=1MHz                                    |         | 25   |      | pF    |
| Turn-ON Delay Time                         | t <sub>d</sub> (on)  | See specified Test Circuit.                                     |         | 17   |      | ns    |
| Rise Time                                  | t <sub>r</sub>       | See specified Test Circuit.                                     |         | 34   |      | ns    |
| Turn-OFF Delay Time                        | t <sub>d</sub> (off) | See specified Test Circuit.                                     |         | 80   |      | ns    |
| Fall Time                                  | tf                   | See specified Test Circuit.                                     |         | 30   |      | ns    |
| Total Gate Charge                          | Qg                   | V <sub>DS</sub> =200V, V <sub>GS</sub> =10V, I <sub>D</sub> =7A |         | 23.5 |      | nC    |
| Gate-to-Source Charge                      | Qgs                  | V <sub>DS</sub> =200V, V <sub>GS</sub> =10V, I <sub>D</sub> =7A |         | 4.5  |      | nC    |
| Gate-to-Drain "Miller" Charge              | Qgd                  | V <sub>DS</sub> =200V, V <sub>GS</sub> =10V, I <sub>D</sub> =7A |         | 13.5 |      | nC    |
| Diode Forward Voltage                      | V <sub>SD</sub>      | I <sub>S</sub> =7A, V <sub>GS</sub> =0V                         |         | 0.9  | 1.2  | ٧     |

# **Package Dimensions**

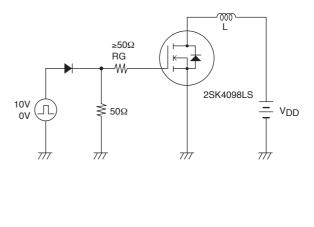
unit : mm (typ) 7509-002



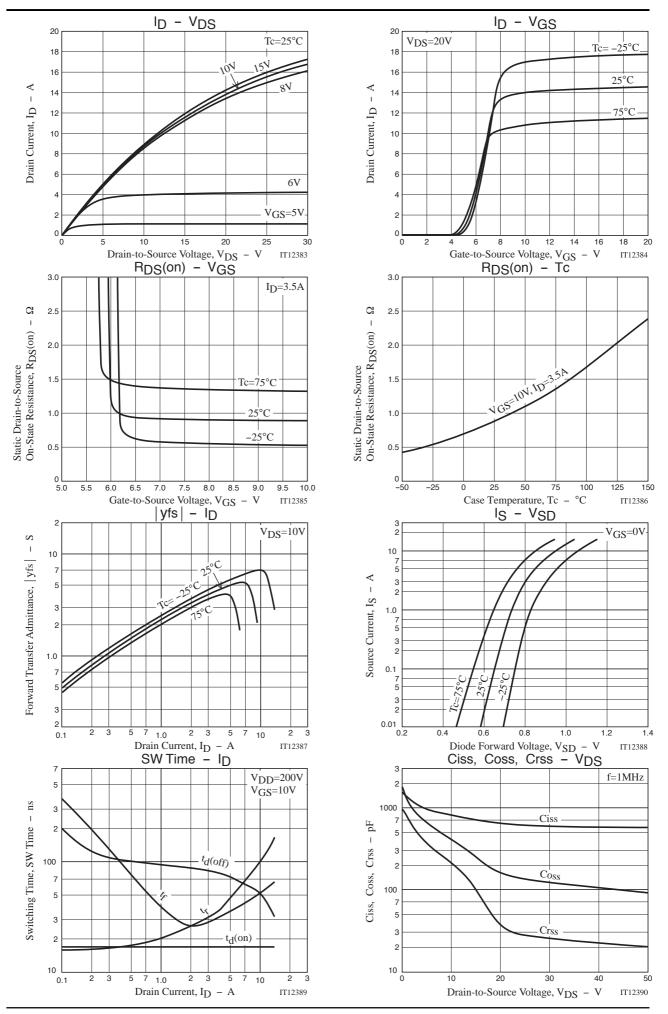
## **Switching Time Test Circuit**



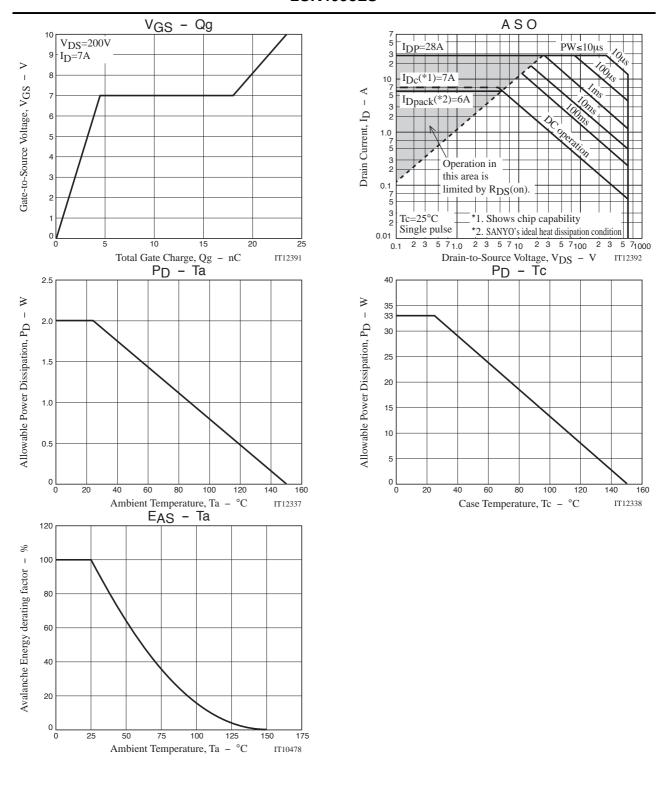
### **Avalanche Resistance Test Circuit**



## 2SK4098LS



## 2SK4098LS



Note on usage: Since the 2SK4098LS is a MOSFET product, please avoid using this device in the vicinity of highly charged objects.

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